Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/049,816	NISHII ET AL.
Examiner	Art Unit
John R. Hardee	1751

SEARCHED					
Class	Subclass	Date	Examiner		
· · · · · · · · · · · · · · · · · · ·					
-			**		
<u> </u>			•		
i					

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
			·		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PALM inventor and ODP search	7/18/2005	JRH		